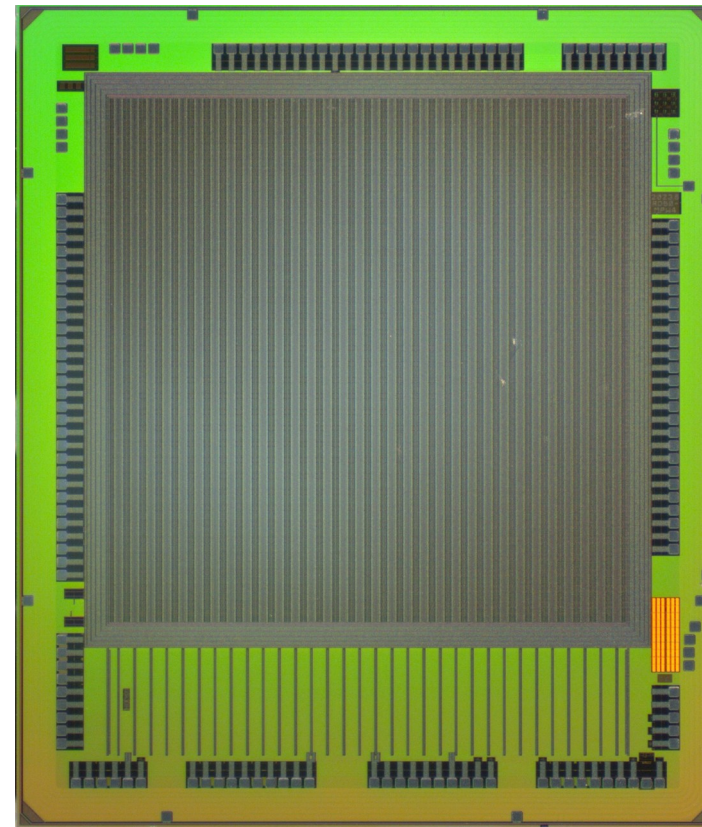
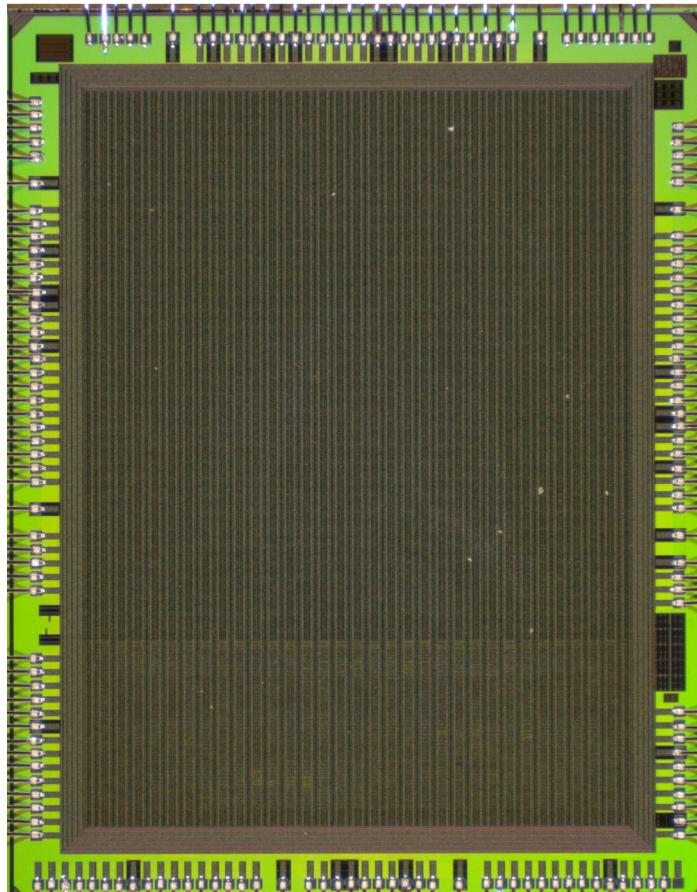
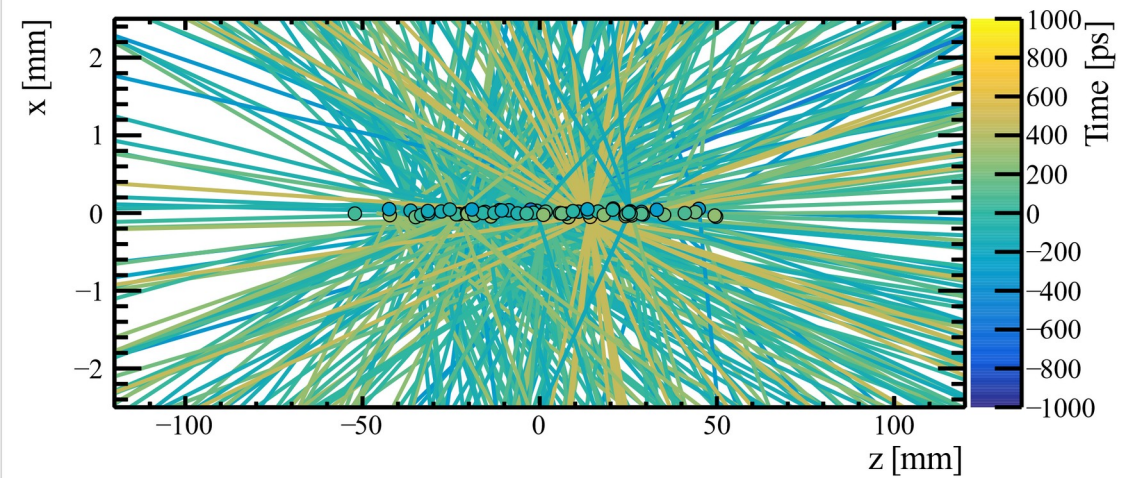


Timing performance of the RD50-MPW4

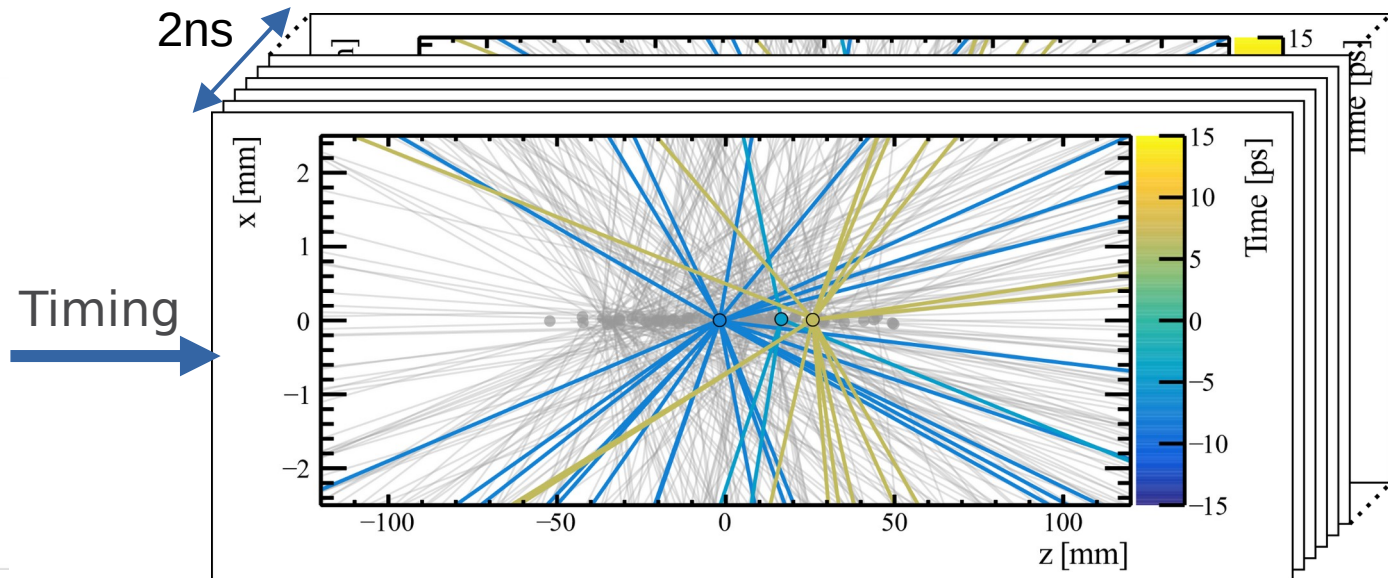


A short, why timing?

- Next future accelerator is the High-Luminosity upgrade of the LHC
 - More collisions per interaction window
 - Higher track densities
 - Higher amounts of radiation
- Track time resolution ~ 30 ps can resolve many of these issues \rightarrow 4D Tracking



© LHCb Collaboration

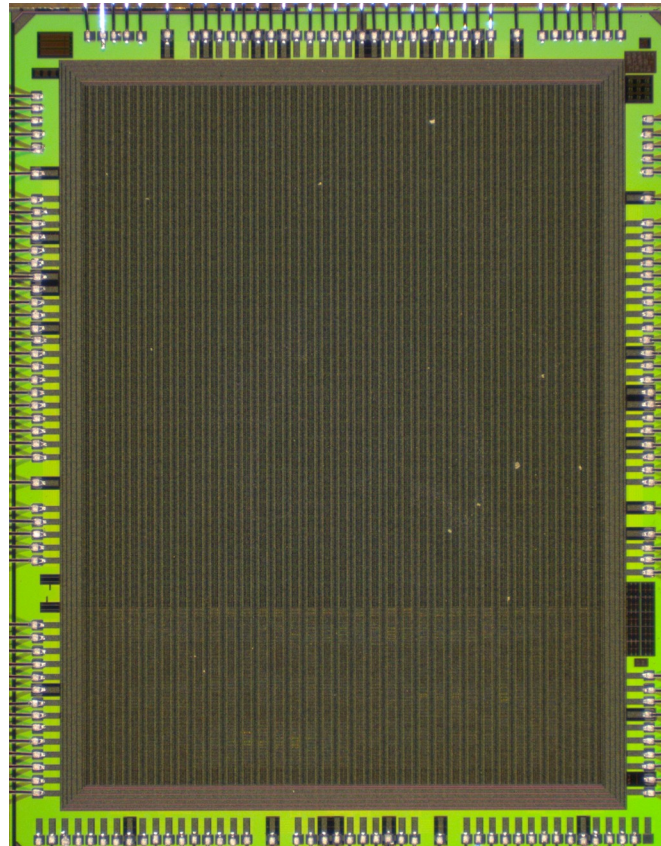


© LHCb Collaboration

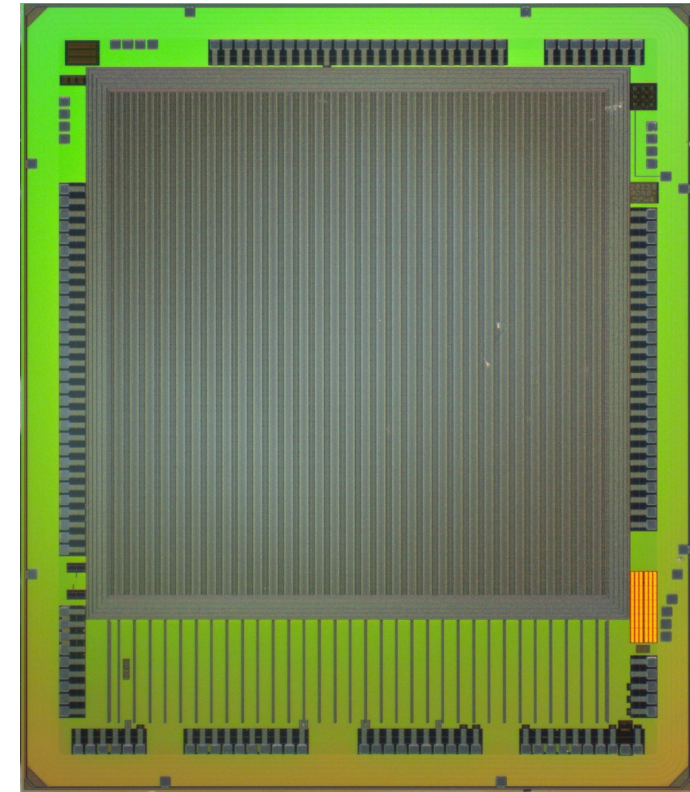
MPW3 and MPW4

- Investigated both MPW3 and MPW4
 - MPW4 not available when Thijs started
 - Wished to investigate differences between the two
- Select MPW3 results are in backup as they are not as relevant for this talk
- All MPW4 results are based on the topside biasable version
- Time with MPW4 was limited for Thijs.

MPW3
(Sep.2023-Jan.2024)



MPW4
(Jan.2024-Mar.2024)



MPW3 (@13000e-)

- Strong difference between clock on and off

- Larger variance in ToT
 - Worse charge calibration
- Larger variance in ToA
 - Worse time resolution

$$\sigma_t = \sqrt{\text{var}(\text{ToA})}$$

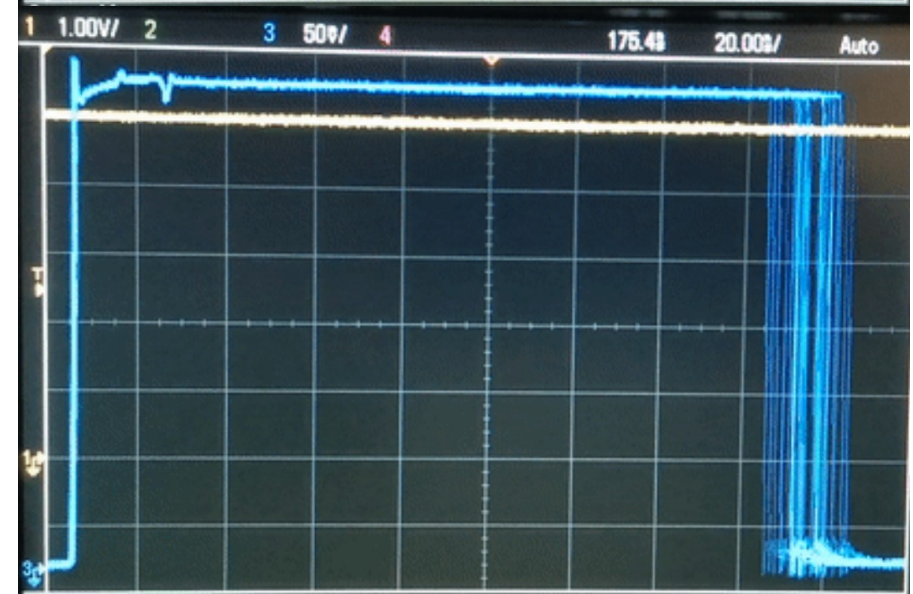
- Clock on = ~2 ns
- Clock off = ~293 ps

- Investigated whether issue is present still in MPW4

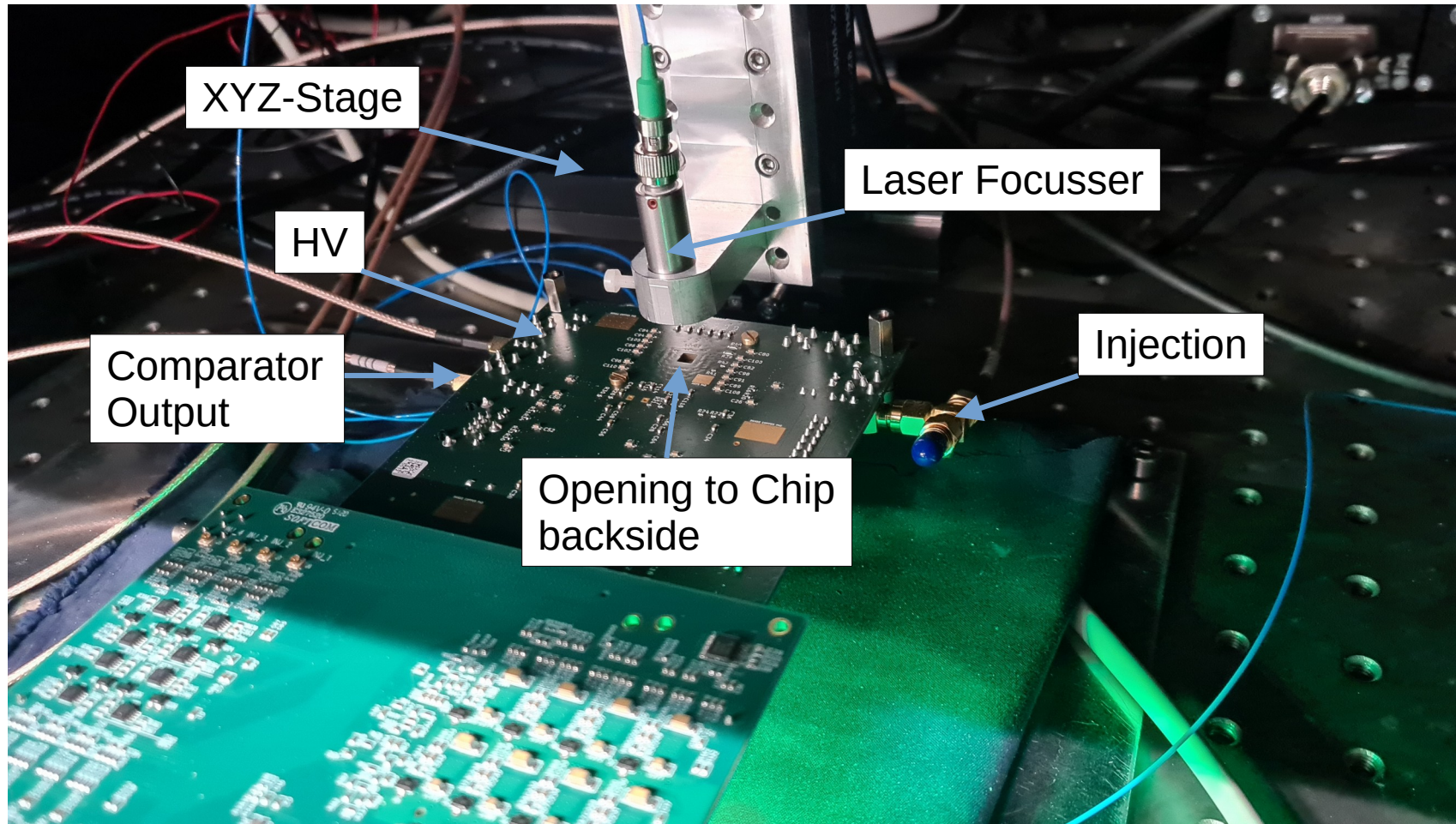
Clock
On



Clock
Off

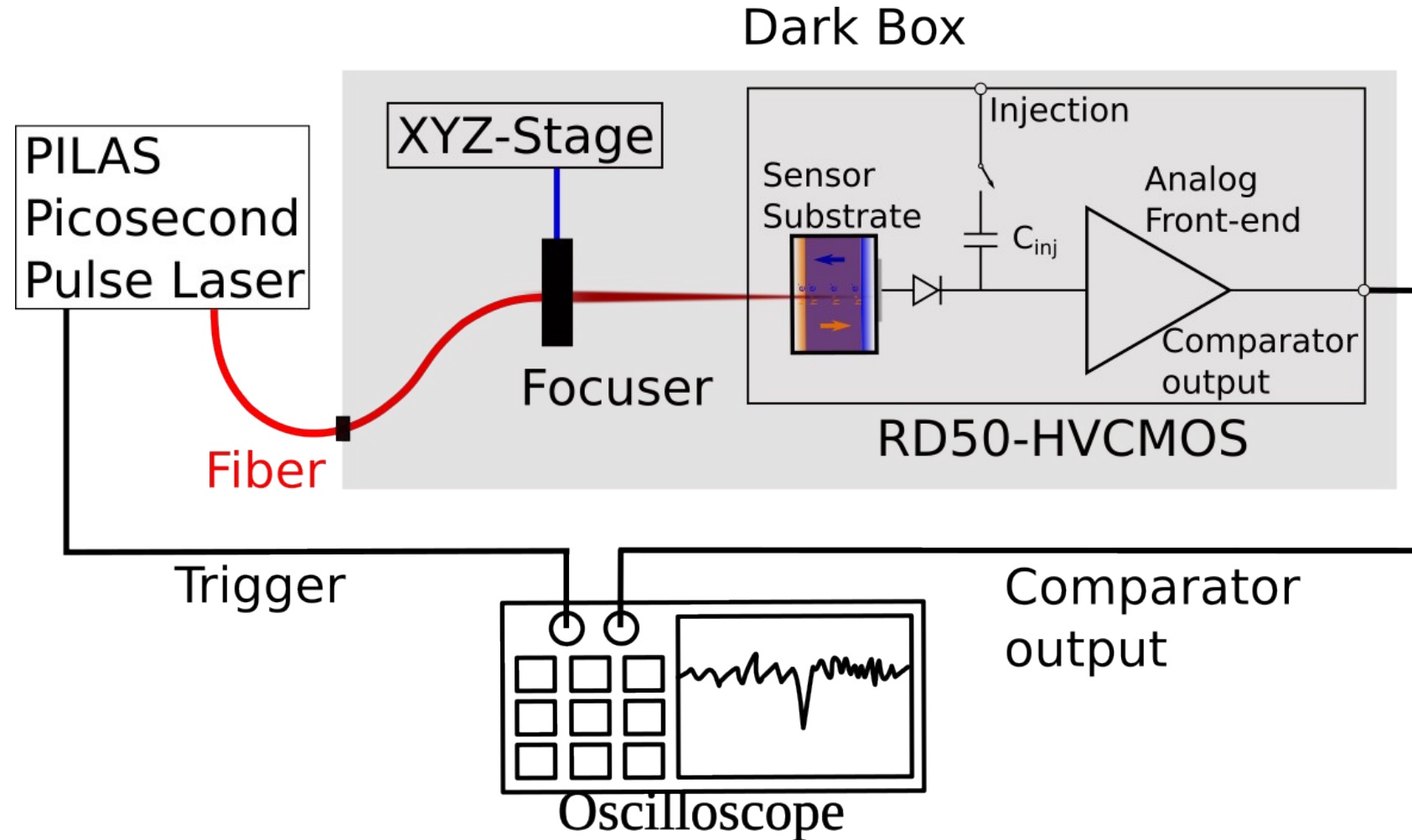


Measurement Setup at Nikhef



Measurement Setup at Nikhef

- CHECK THESE VALUES AGAIN
- PILAS picosecond pulse Laser (FastSPA)
 - 940 nm
 - $t_{\text{jitter}} = \sim 1.9 \text{ ps}$
 - $t_{\text{rise}} = \sim 35 \text{ ps}$
 - $t_{\text{pulse}} = \sim 46 \text{ ps}$
 - $E_{\text{pulse}} = \sim 5 \text{ pJ}$
 - $f_{\text{pulse}} = 40 \text{ MHz}$



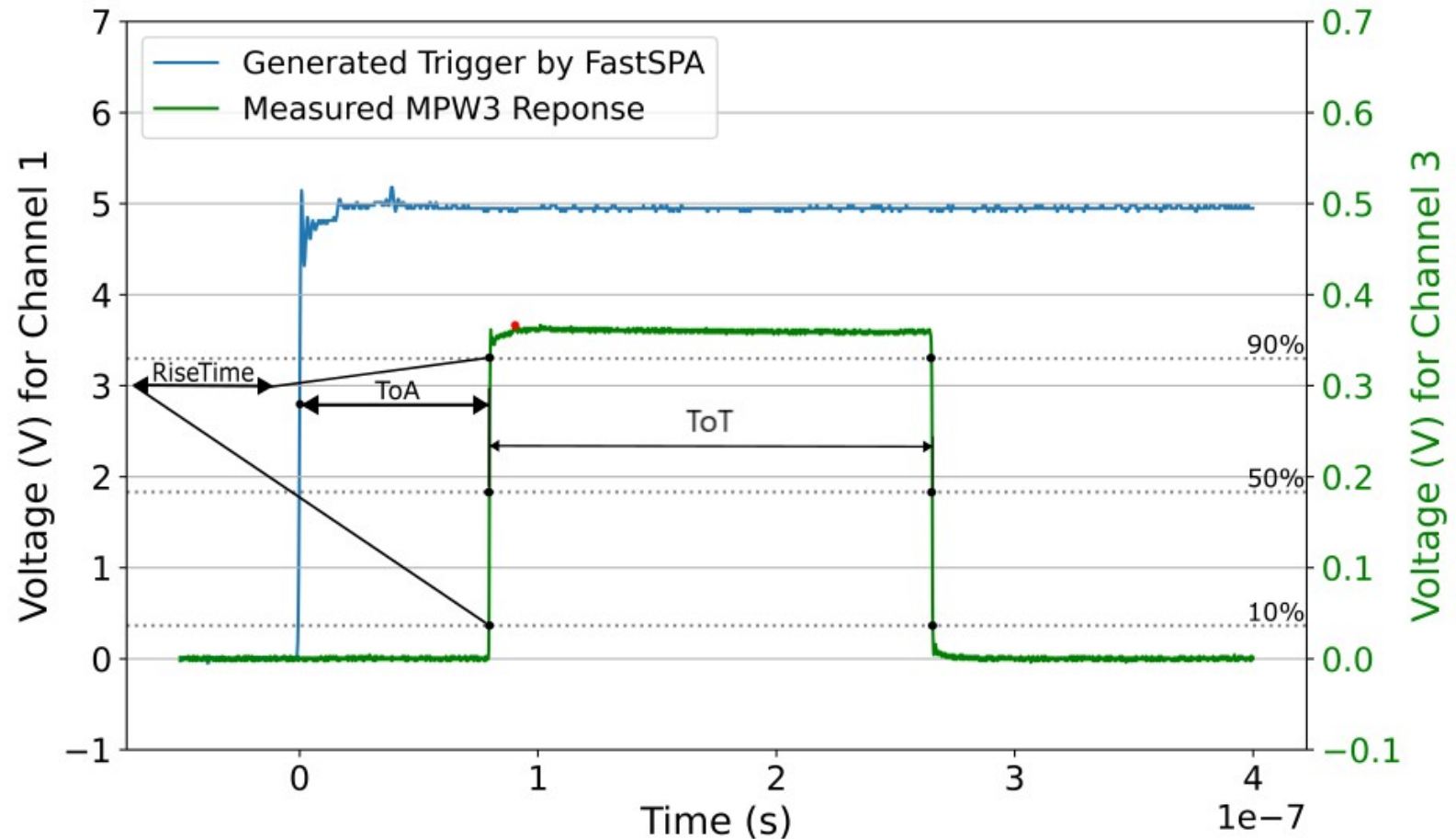
What we measure

- Mainly interested in timing performance of HV-CMOS technology
 - Analog only
 - Read out using Scope Ifiniium MXR604A
6 GHz, 16 Gsa/s, 10 bit

- $t_{\text{rise}} = t_{\text{rise-MPW-90\%}} - t_{\text{rise-MPW-10\%}}$
- $ToT = t_{\text{fall-MPW-50\%}} - t_{\text{rise-MPW-50\%}}$
- $ToA = t_{\text{rise-MPW-50\%}} - t_{\text{rise-trig-50\%}}$

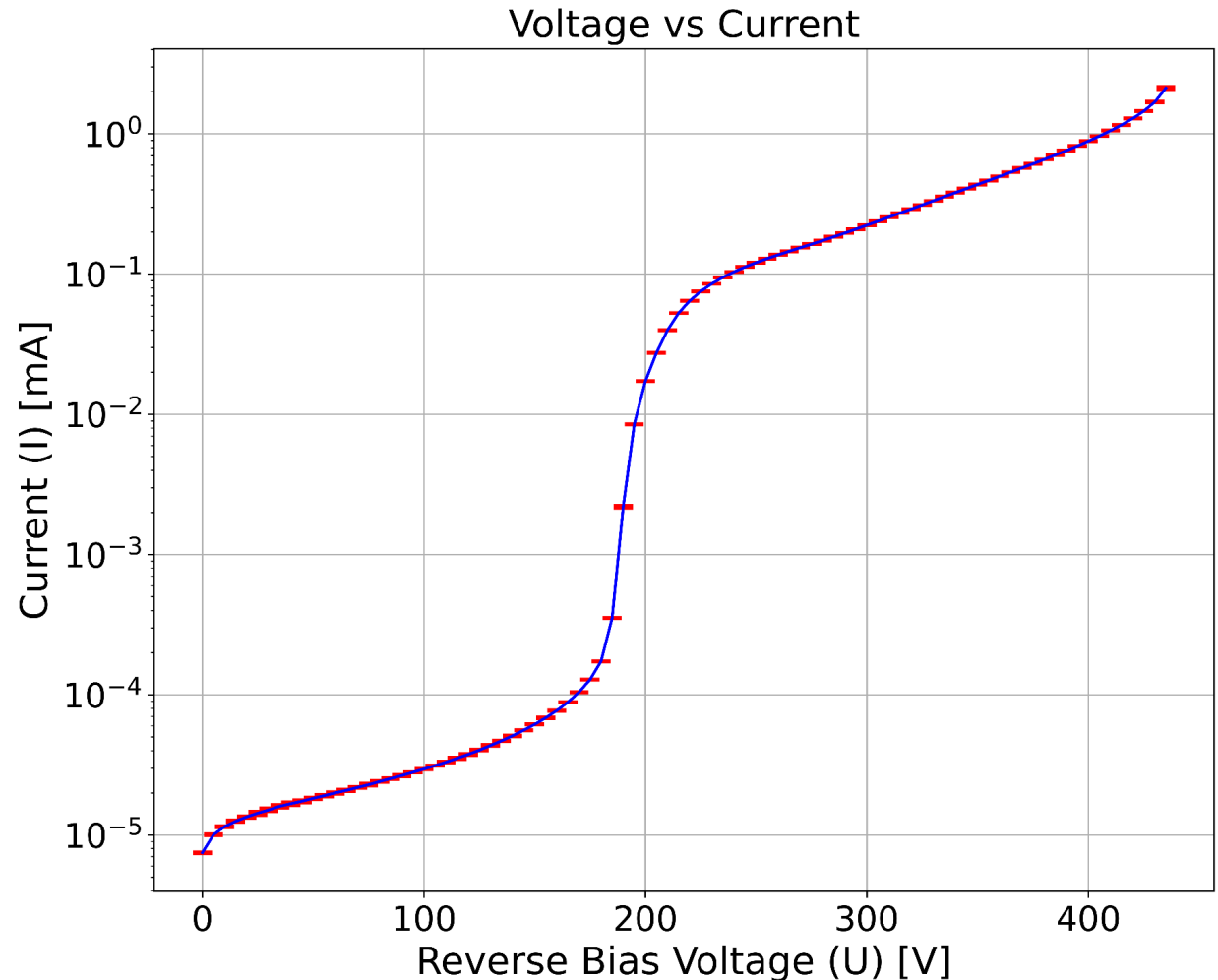
$$\sigma_t = \sqrt{\text{var}(ToA)}$$

- Limited by unavailability of direct source follower output. (Need to test if Abuffout works as I hope)



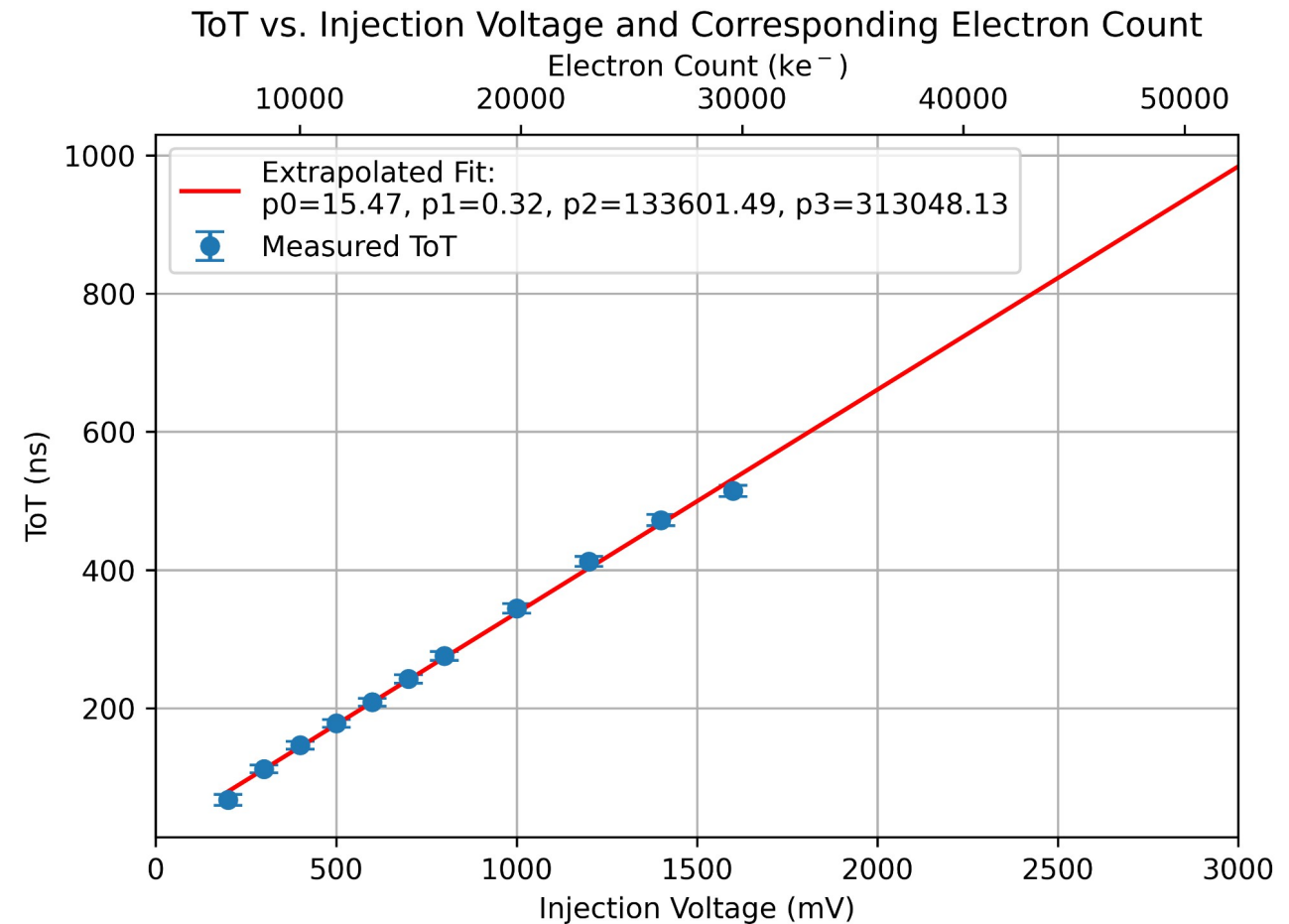
IV curve of MPW4 (topside, full chip)

- Biased MPW4 up to 500V
- Large increase in current at 200V could be due to reach of backside + backside defects
- True breakdown begins at around 500V



ToT to Charge Calibration (single pixel)

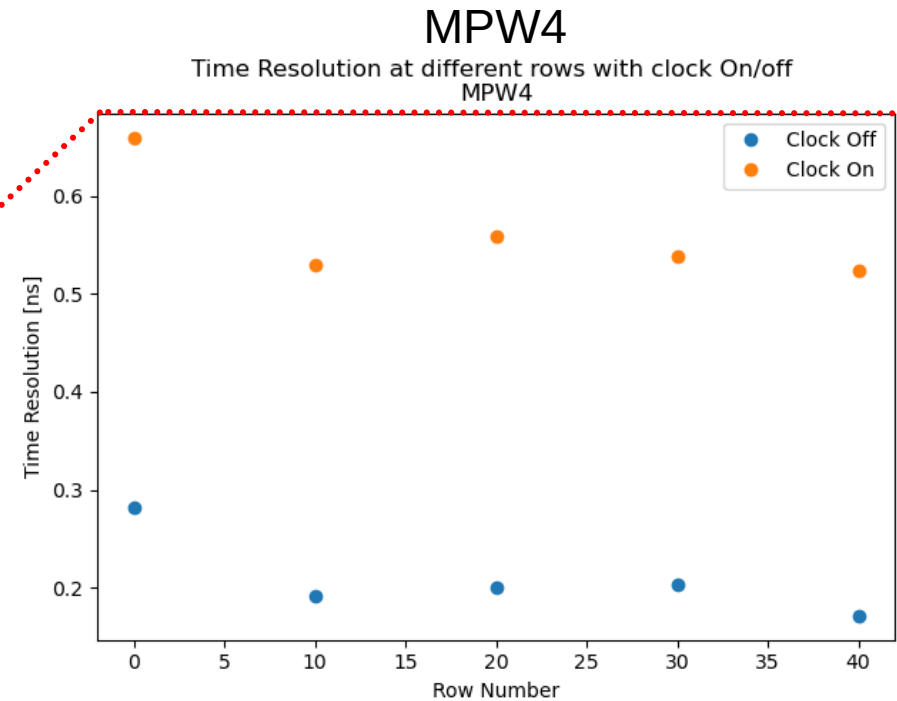
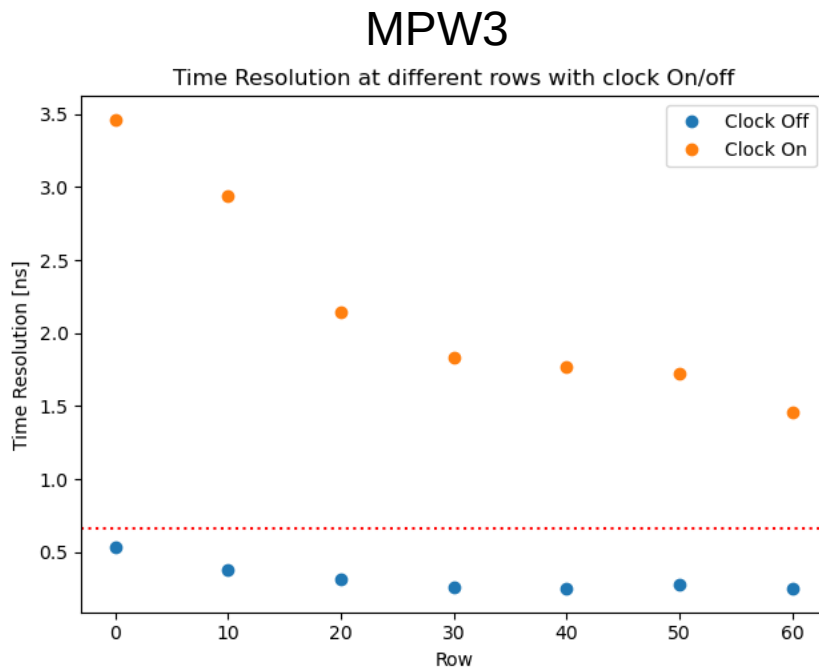
- Performed standard charge calibration using injection voltages
- Original plan was to perform this for all pixels, and scan in pixel effects.
- Limited time meant focus was shifted to comparison with MPW3 results concerning periphery noise with clock and and off



Time resolution MPW3 vs MPW4

- Results are more qualitative (injected charge via laser differs)
- Overall time resolution for MPW4 is far better due to reduced noise in the periphery
- Clock effects are still present in the performance
- Some effect of closeness to periphery persists

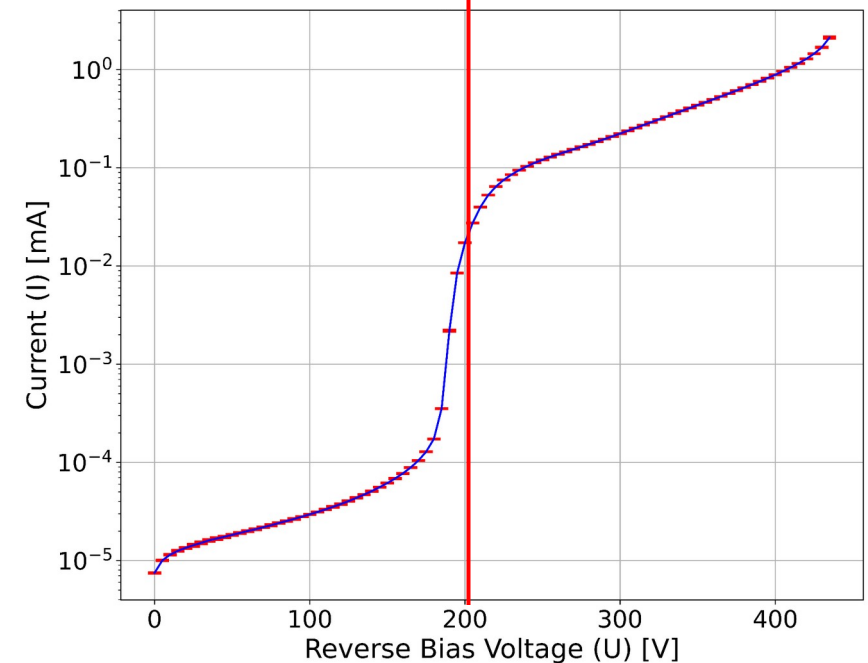
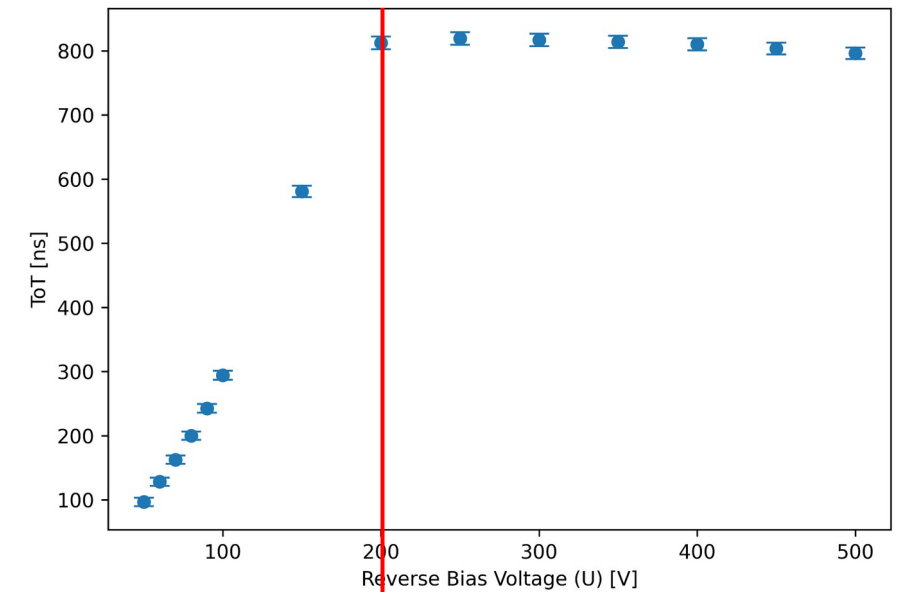
$$\sigma_t \propto \frac{dV/dt}{\sqrt{S/N}}$$



Improving the Time Resolution

- Overdepletion increases electric field strength
 - → Faster charge collection
 - → Higher dV/dt
 - → Improves time resolution
- ToT increase stops around 200V
- Similar to the the large increase of current
 - Further indicates reach of full depletion
 - → Any voltage above 200V should improve time resolution

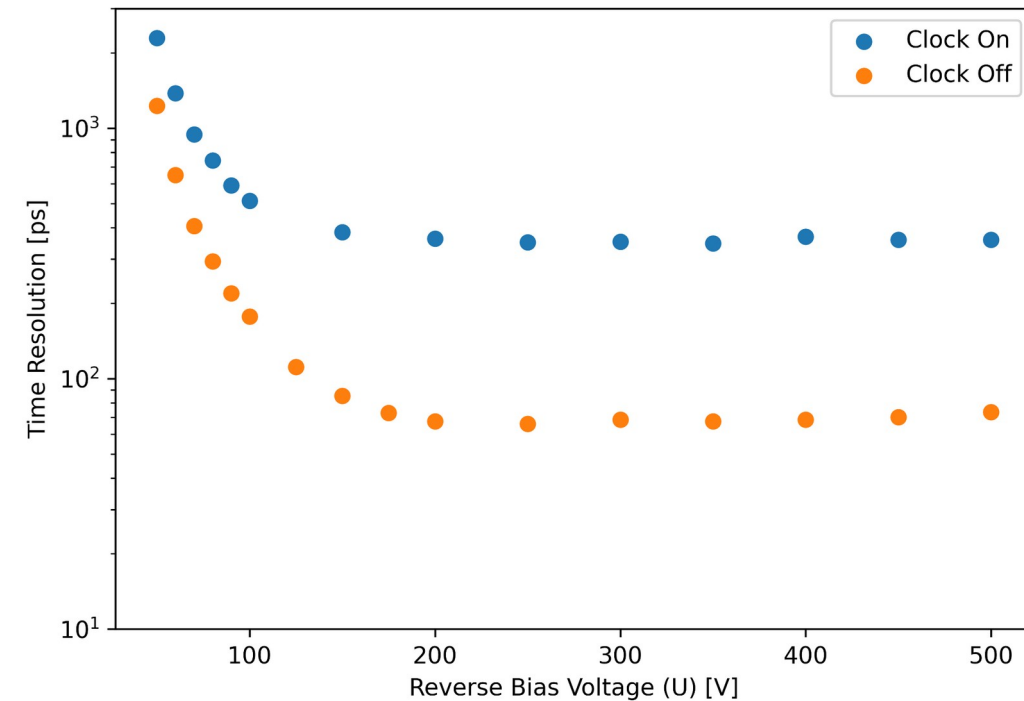
ToT at different Reverse Bias
MPW4



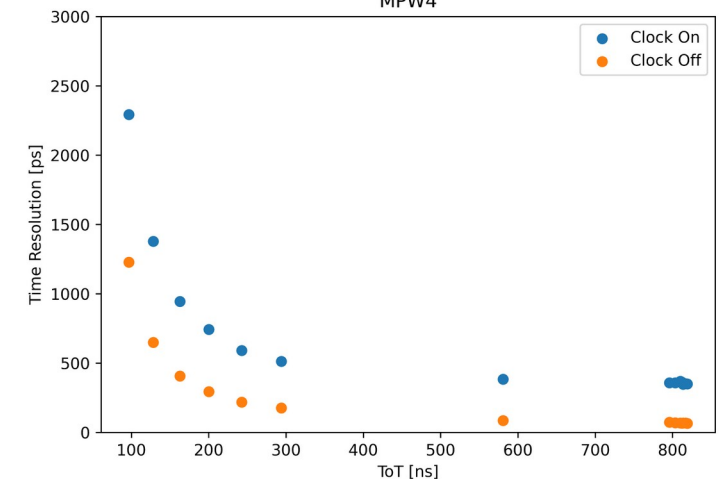
Improving the Time Resolution

- Unfortunately charge injected was far beyond expected MIP (44000e-)
 - No time to repeat
- Mostly looking at trends
- Time resolution improves up until 200V
 - Same as increase in measured charge
 - Result most likely just based on Timewalk
- No effect of overdepletion visible in the behavior

ToT at different Reverse Bias
MPW4



Time Resolution at ToT
MPW4



Conclusion

- The MPW4 is far better than its predecessor in terms of noise and time resolution
- Current iteration of chip can reach $O(500/200 \text{ ps})$ analog time resolution (clock on/off)
- Still not insignificant noise present in the system when clock is active

Outlook

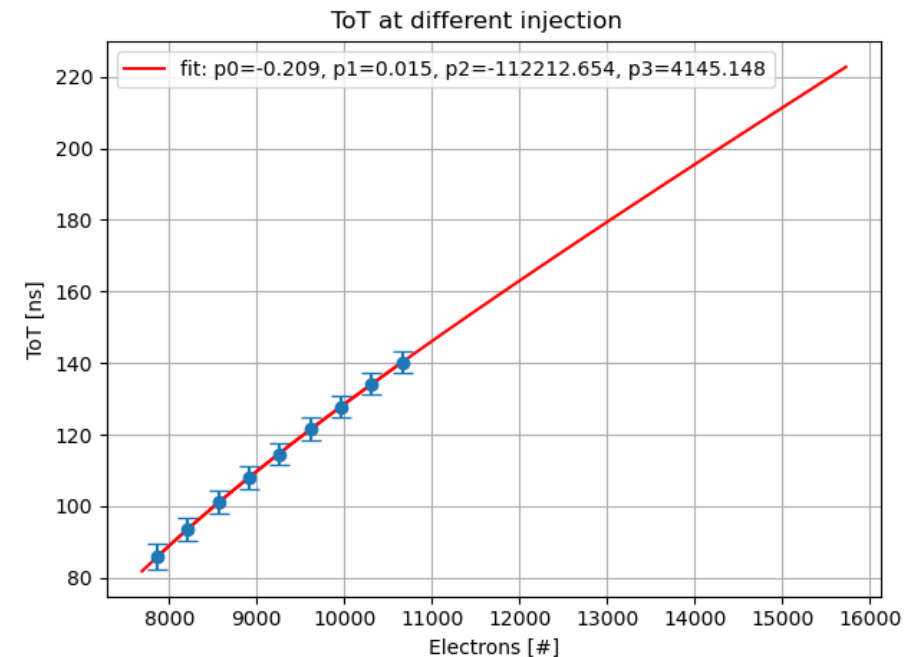
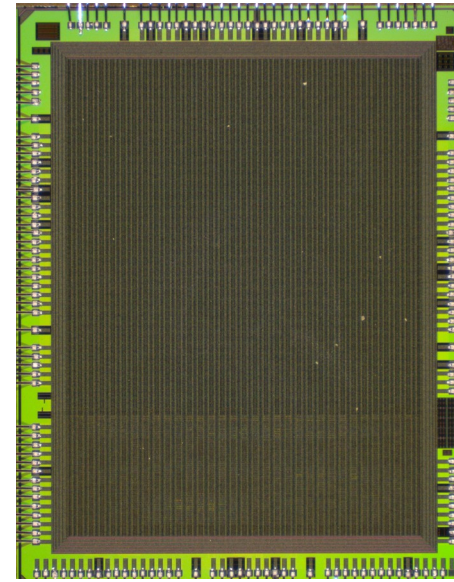
- Possible that improvement of time resolution with higher bias was not visible due to limitation from the Amplifier (low Bandwidth?)
- Amplifier current DAC was already set to one of the highest values as far as I remember.
- Do not expect to see any differences in in-pixel relative to MPW2 outside of the matrix border.
- Interested to investigate differences in measured charge, noise and time resolution both over the row and in-pixel for irradiated vs non-irradiated sensors. (requires a new student)
- For more detailed investigation into advantages of HV-CMOS relative to HR-CMOS in terms of 4D-tracking, access to analog signals, timing optimized front-end (larger amplifier current range) and possible investigations into variations of the well layouting would be of interest.

BACKUP

(MPW3+ Super Simple Timing)

MPW3 results

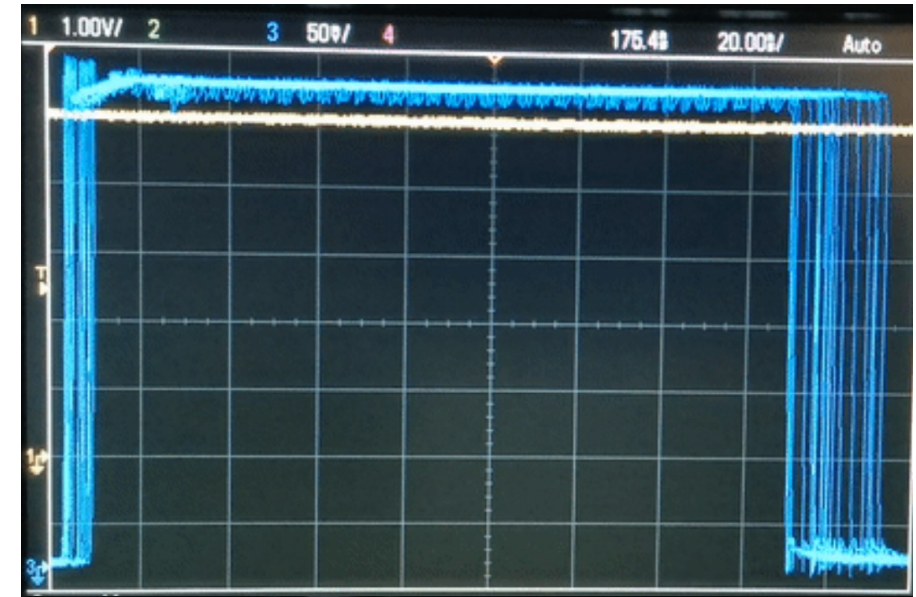
- MPW3 was measured at
 - 100V bias
 - Standard DAC values
 - Clock on and clock off
- What was measured
 - Analog only
 - Charge calibration of pixels using charge injection via pulse generator
 - Time resolution
 - Row dependence of results



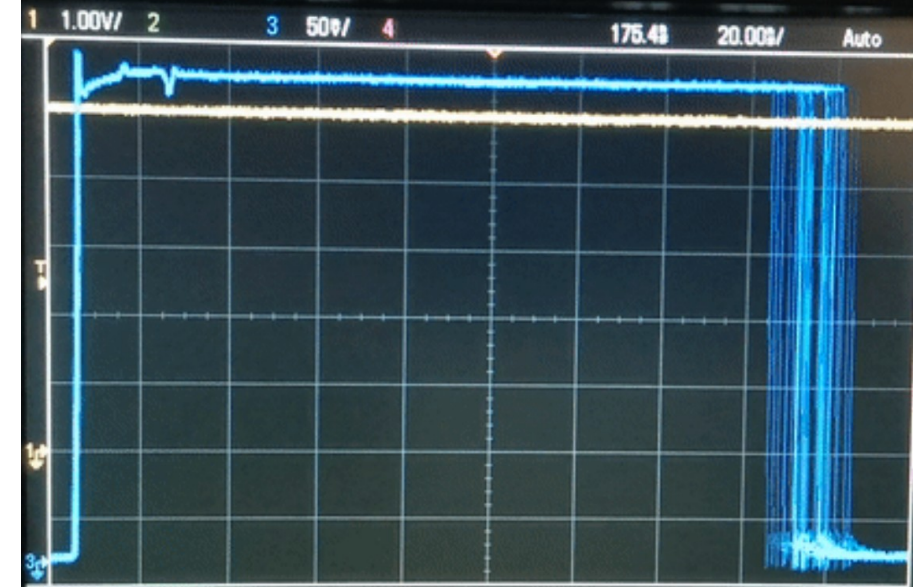
MPW3 (@13000e-)

- Strong difference between clock on and off

Clock
On



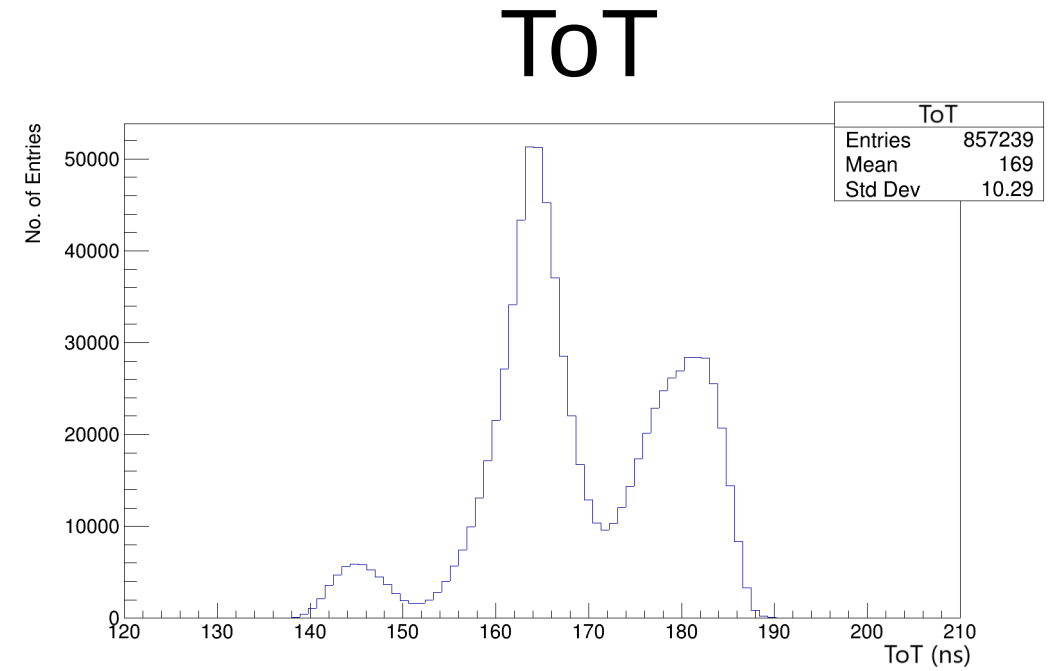
Clock
Off



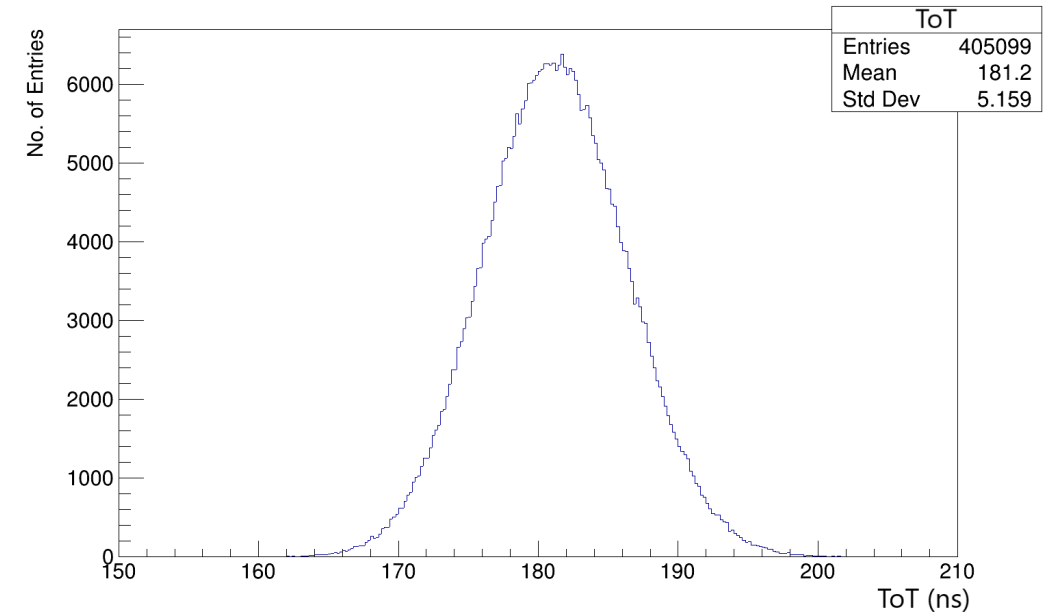
MPW3 (@13000e-)

- Strong difference between clock on and off
 - Larger variance in ToT
 - Worse charge calibration

Clock On



Clock Off

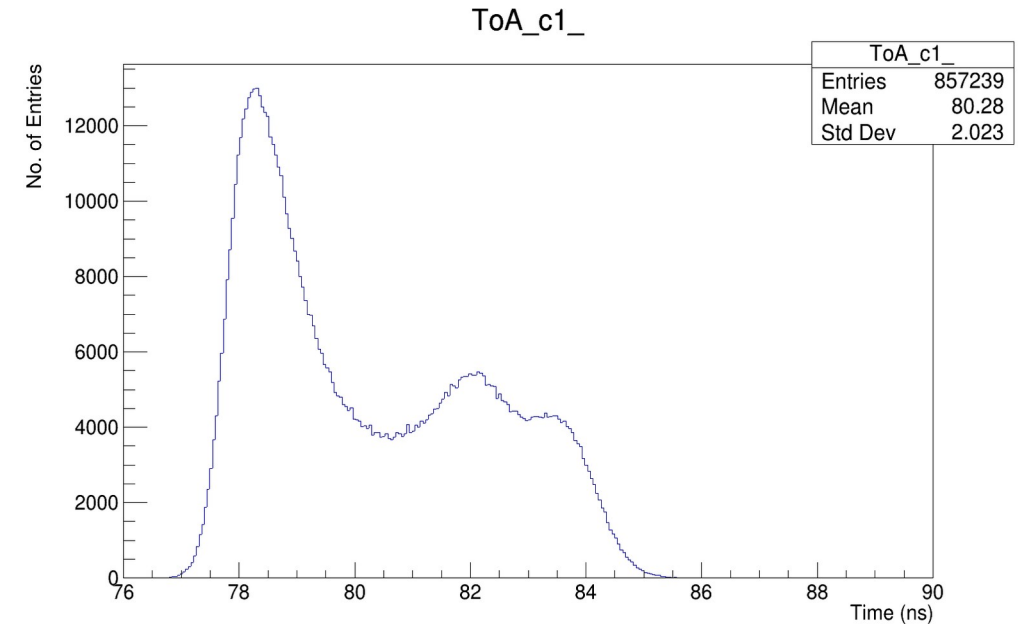


MPW3 (@13000e-)

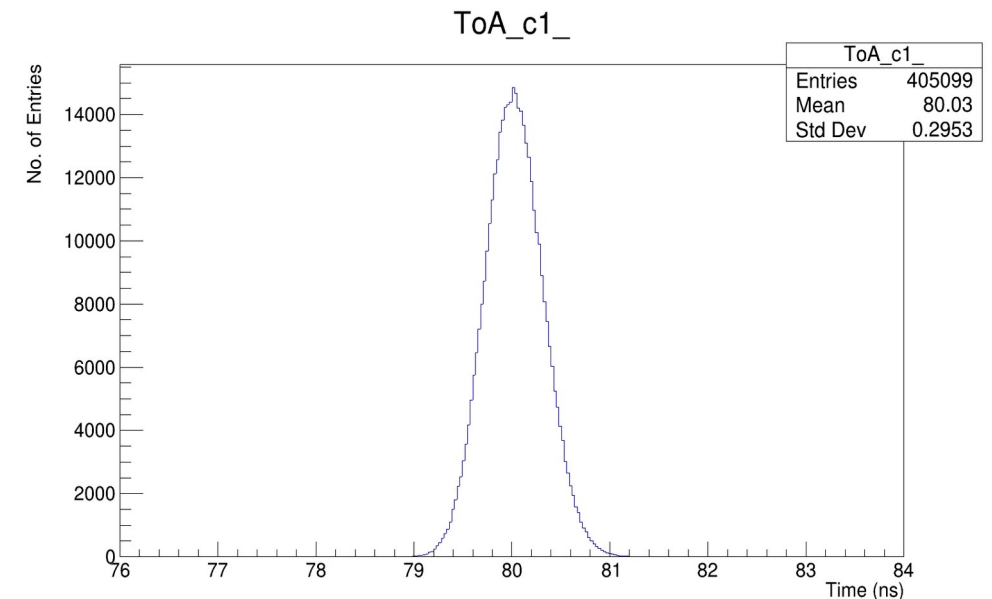
- Strong difference between clock on and off
 - Larger variance in ToT
 - Worse charge calibration
 - Larger variance in ToA
 - Worse time resolution

$$\sigma_t = \sqrt{\text{var}(\text{ToA})}$$

Clock
On



Clock
Off



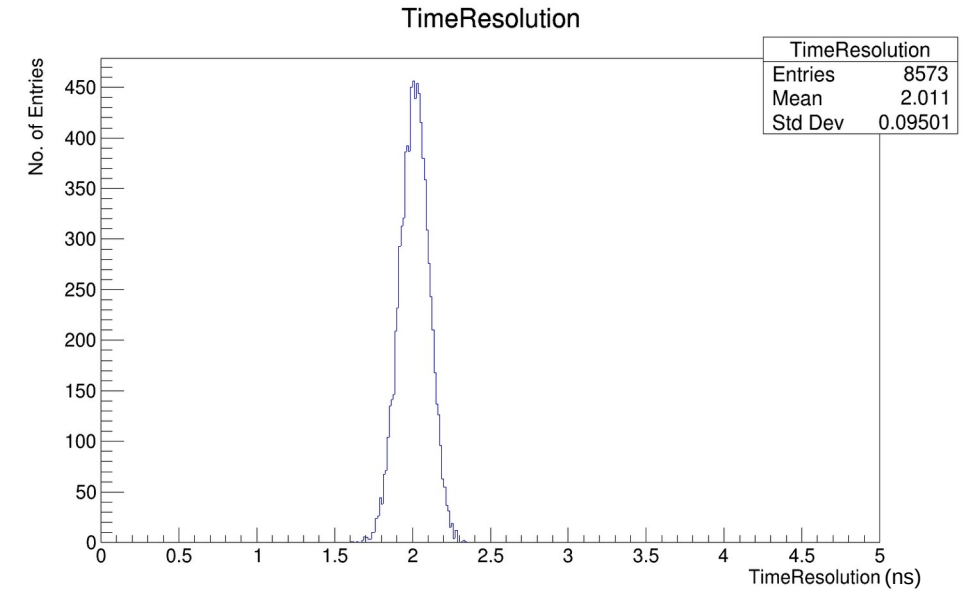
MPW3 (@13000e-)

- Strong difference between clock on and off
 - Larger variance in ToT
 - Worse charge calibration
 - Larger variance in ToA
 - Worse time resolution

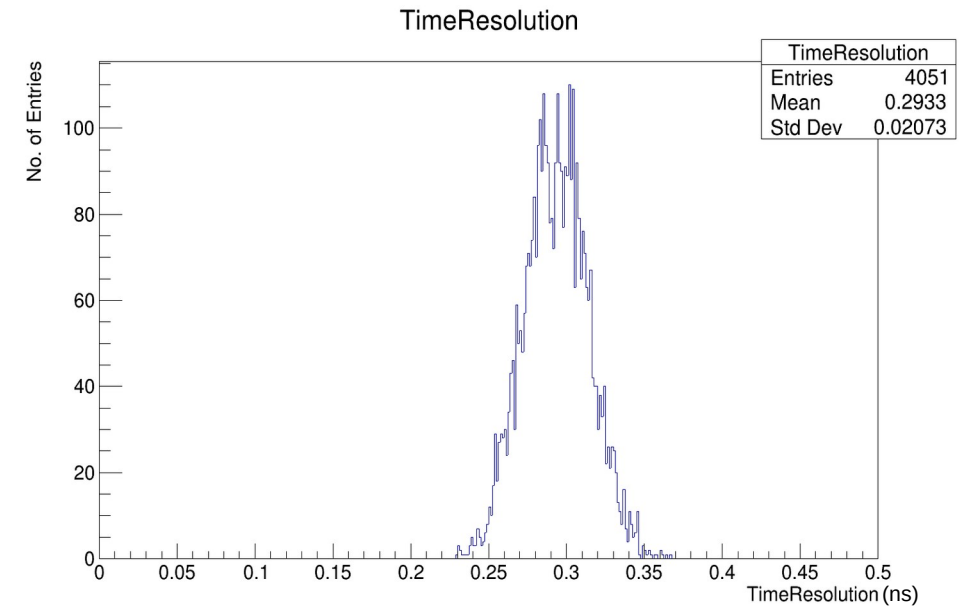
$$\sigma_t = \sqrt{\text{var}(\text{ToA})}$$

- Clock on = ~2 ns
- Clock off = ~293 ps

Clock
On

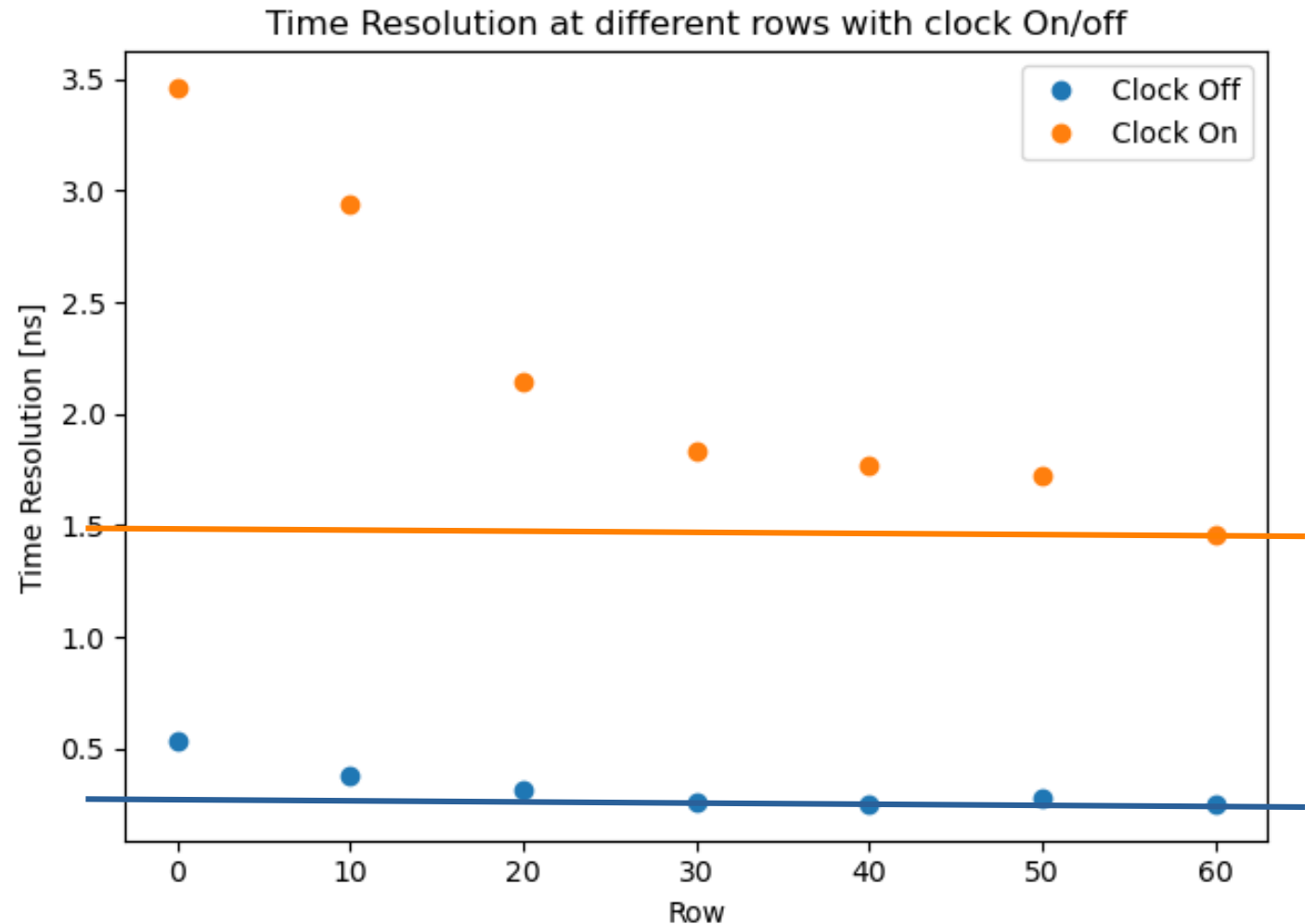


Clock
Off



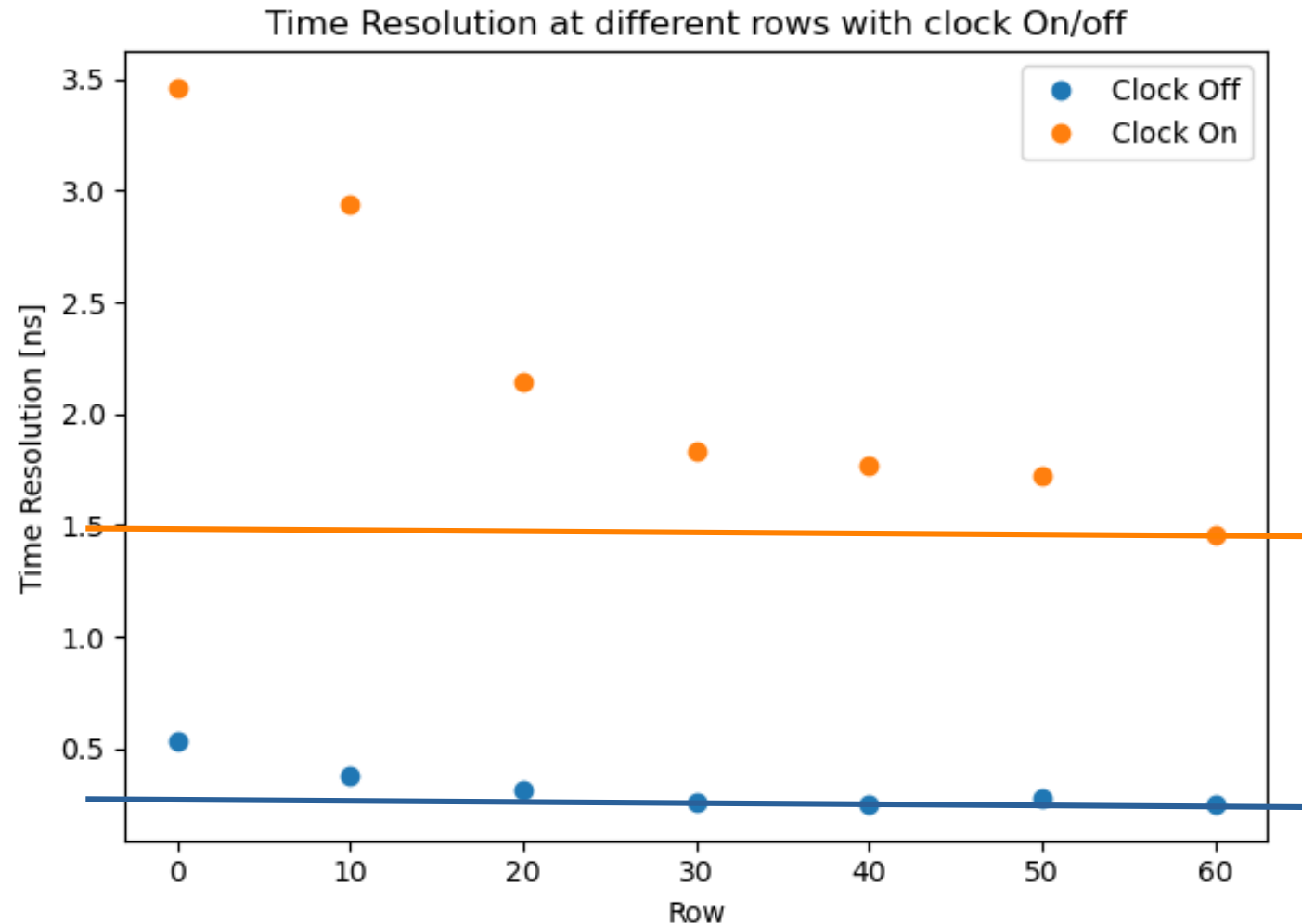
MPW3 for different row values

- Investigated row dependence due to closeness to periphery
- Closer to periphery = Worse time resolution
 - Present in both with and without clock
 - Far stronger with clock on



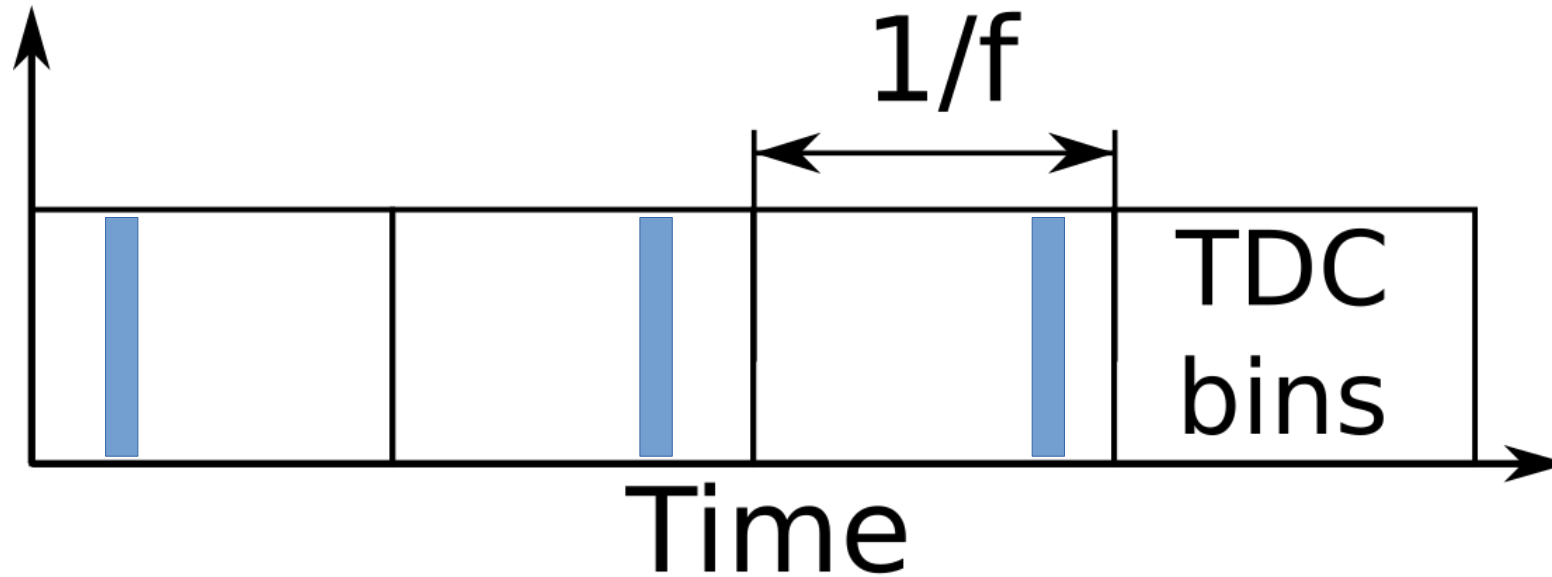
MPW4 for different row values

- Investigated row dependence due to closeness to periphery
- Closer to periphery = Worse time resolution
 - Present in both with and without clock
 - Far stronger with clock on



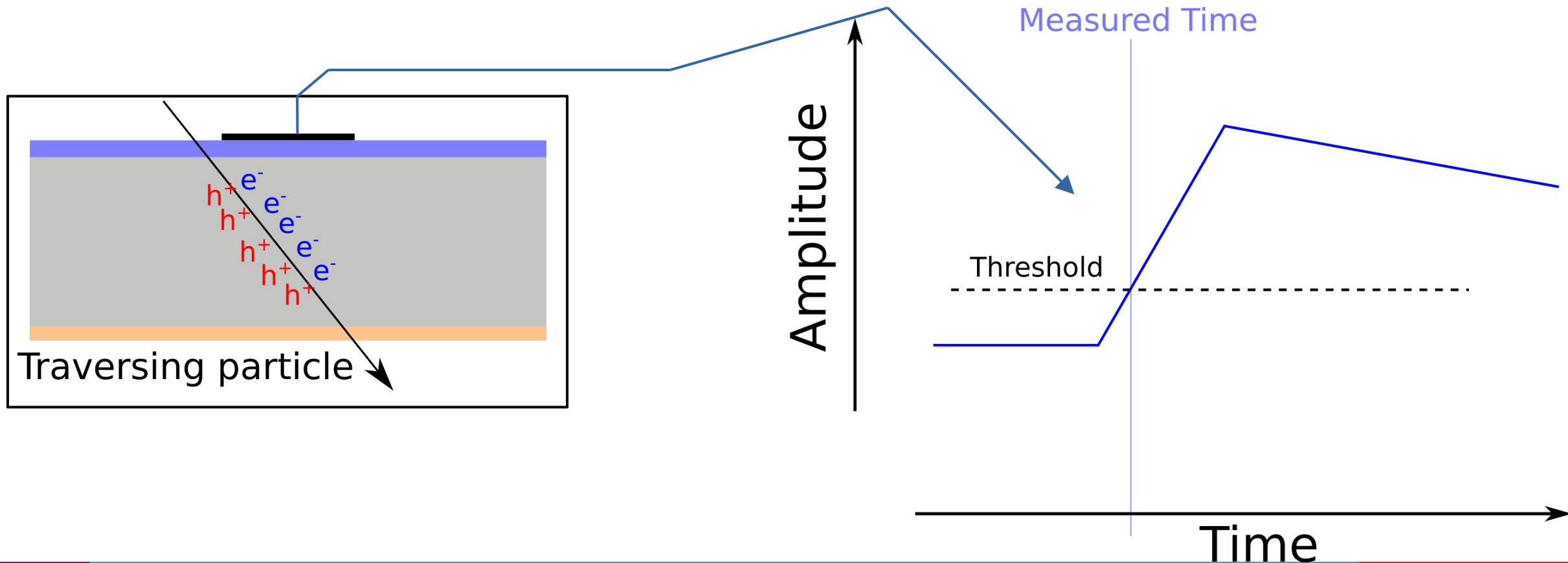
Contributions to time resolution

$$\sigma_t^2 = \sigma_{\text{clock-global}}^2 + \sigma_{\text{clock-on-chip}}^2 + \sigma_{\text{TDC}}^2 + \dots$$



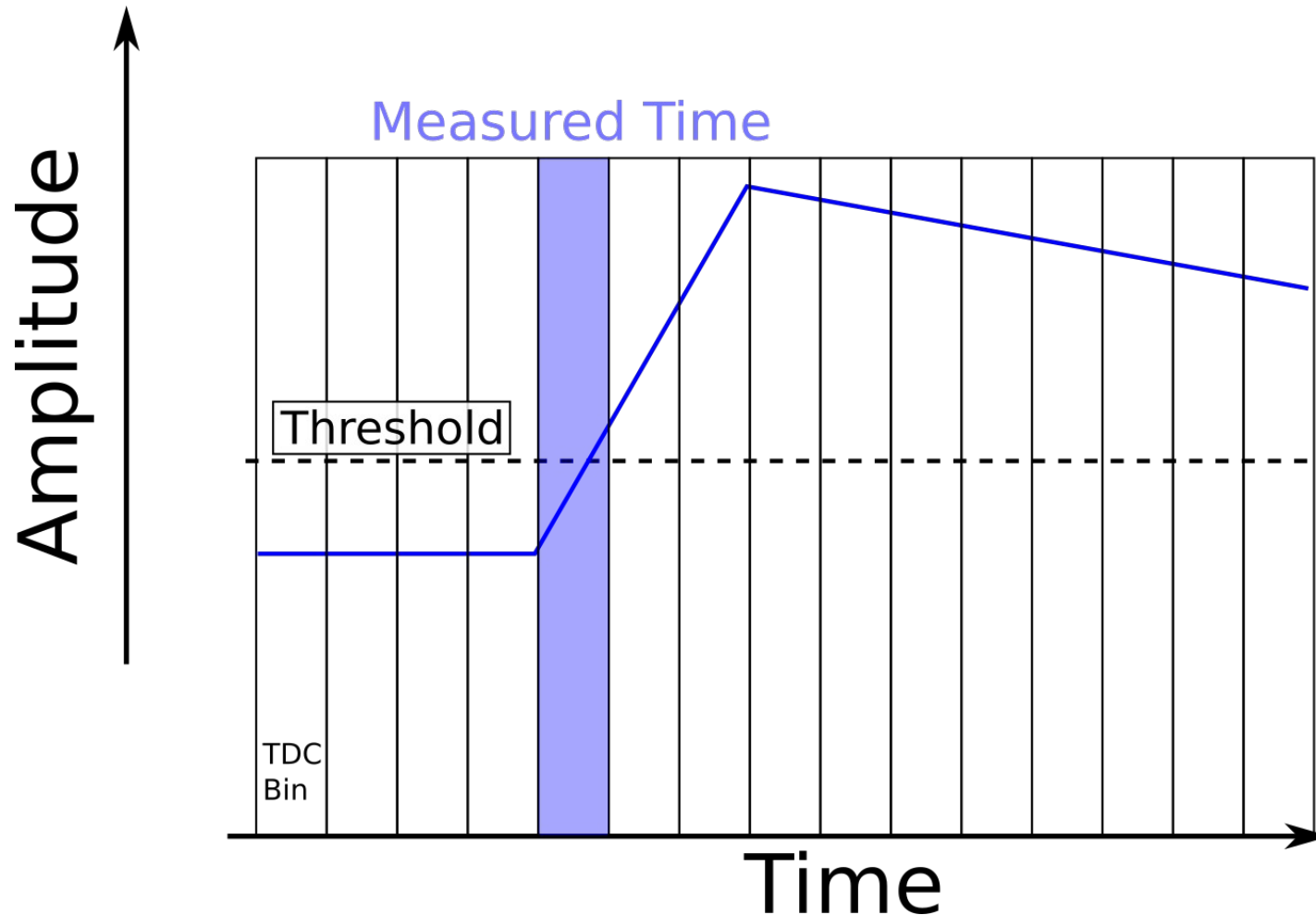
What is actually measured

- Measured is the time when a gathered charge signal crosses a threshold



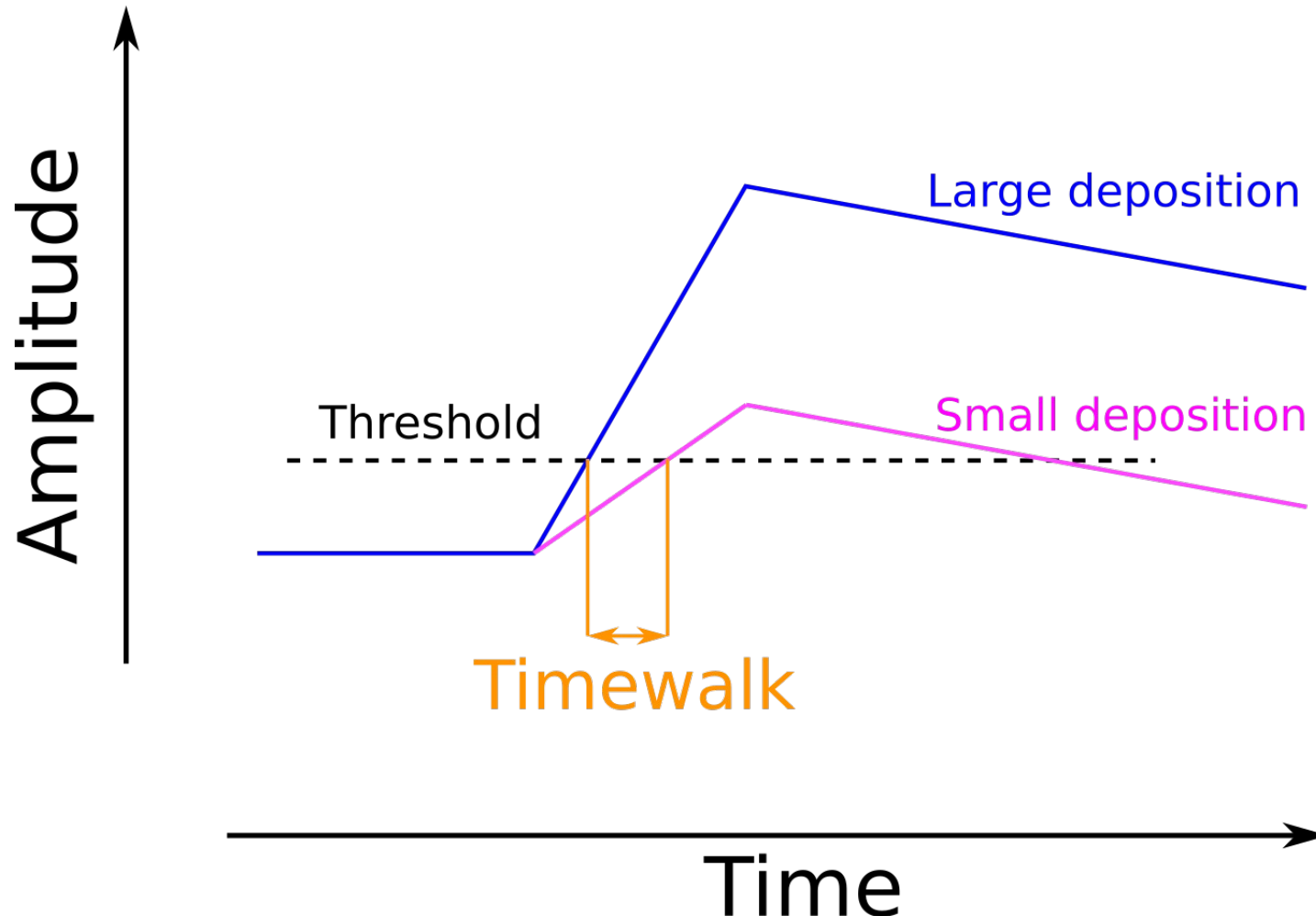
Contributions to time resolution

$$\sigma_t^2 = \sigma_{\text{clock-global}}^2 + \sigma_{\text{clock-on-chip}}^2 + \sigma_{\text{TDC}}^2 + \dots$$



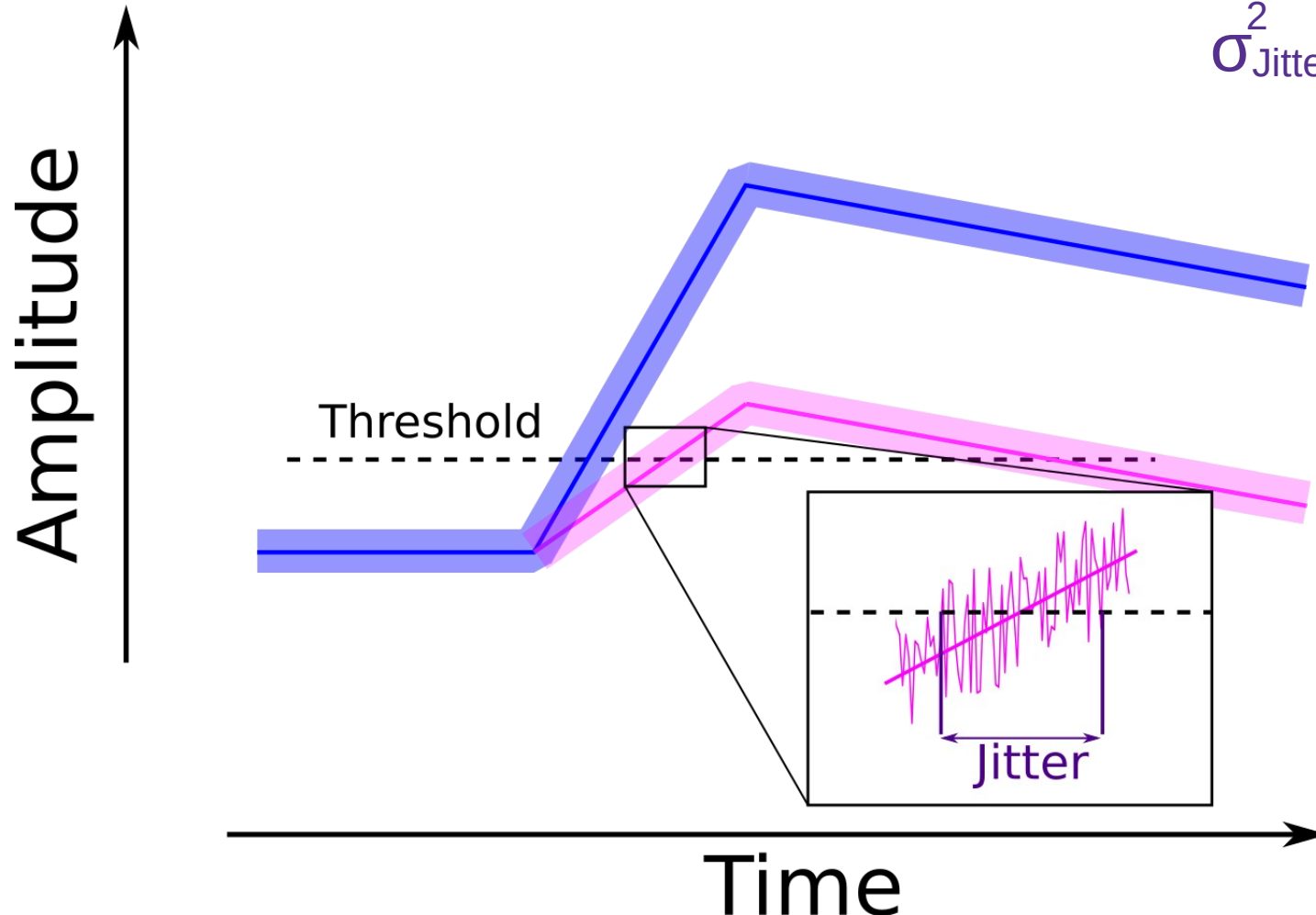
Contributions to time resolution

$$\sigma_t^2 = \sigma_{\text{clock-global}}^2 + \sigma_{\text{clock-on-chip}}^2 + \sigma_{\text{TDC}}^2 + \sigma_{\text{Timewalk}}^2 + \dots$$



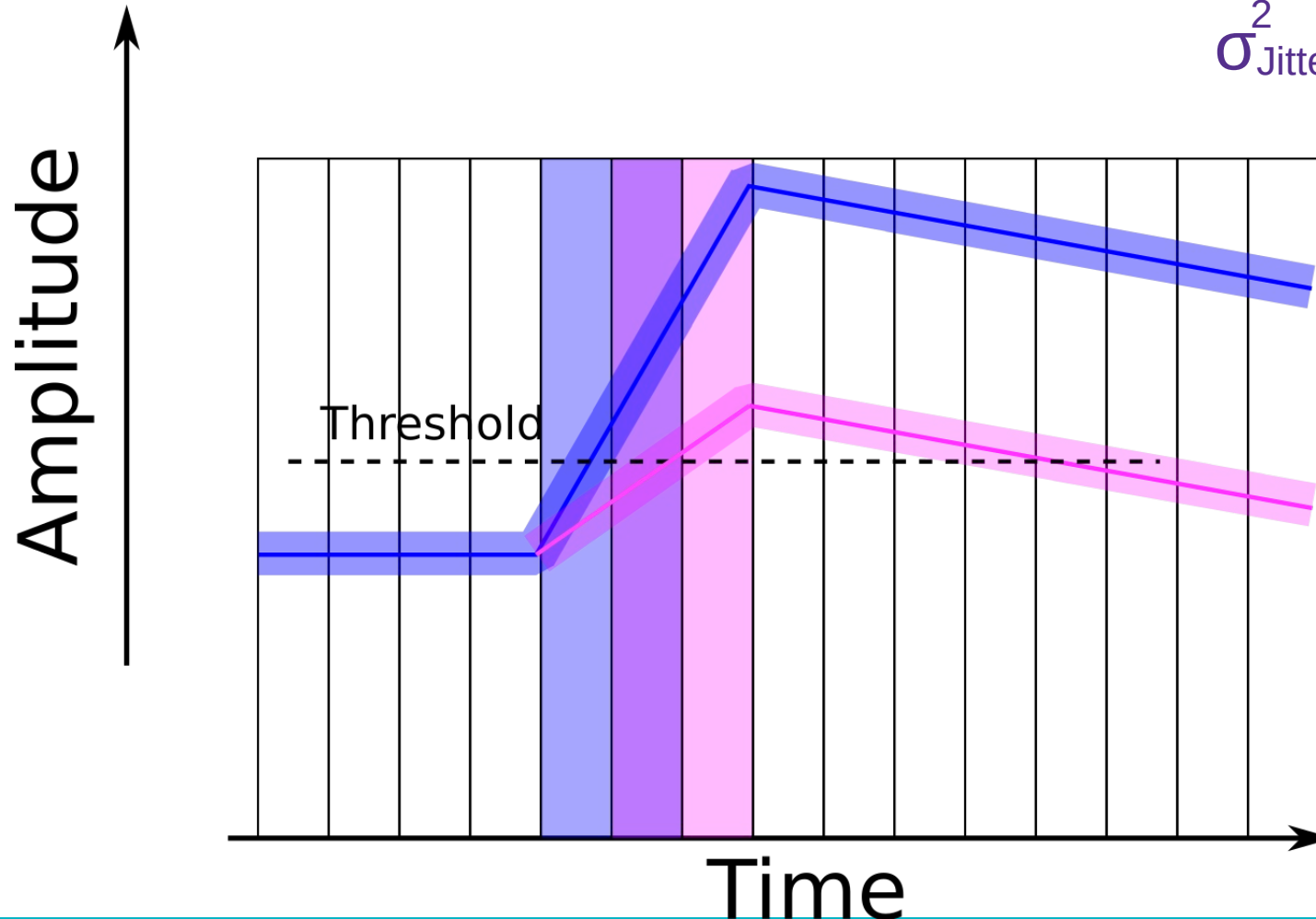
Contributions to time resolution

$$\sigma_t^2 = \sigma_{\text{clock-global}}^2 + \sigma_{\text{clock-on-chip}}^2 + \sigma_{\text{TDC}}^2 + \sigma_{\text{Timewalk}}^2 + \underbrace{\sigma_{\text{Landau}}^2 + \sigma_{\text{Front-end}}^2}_{\sigma_{\text{Jitter}}^2}$$



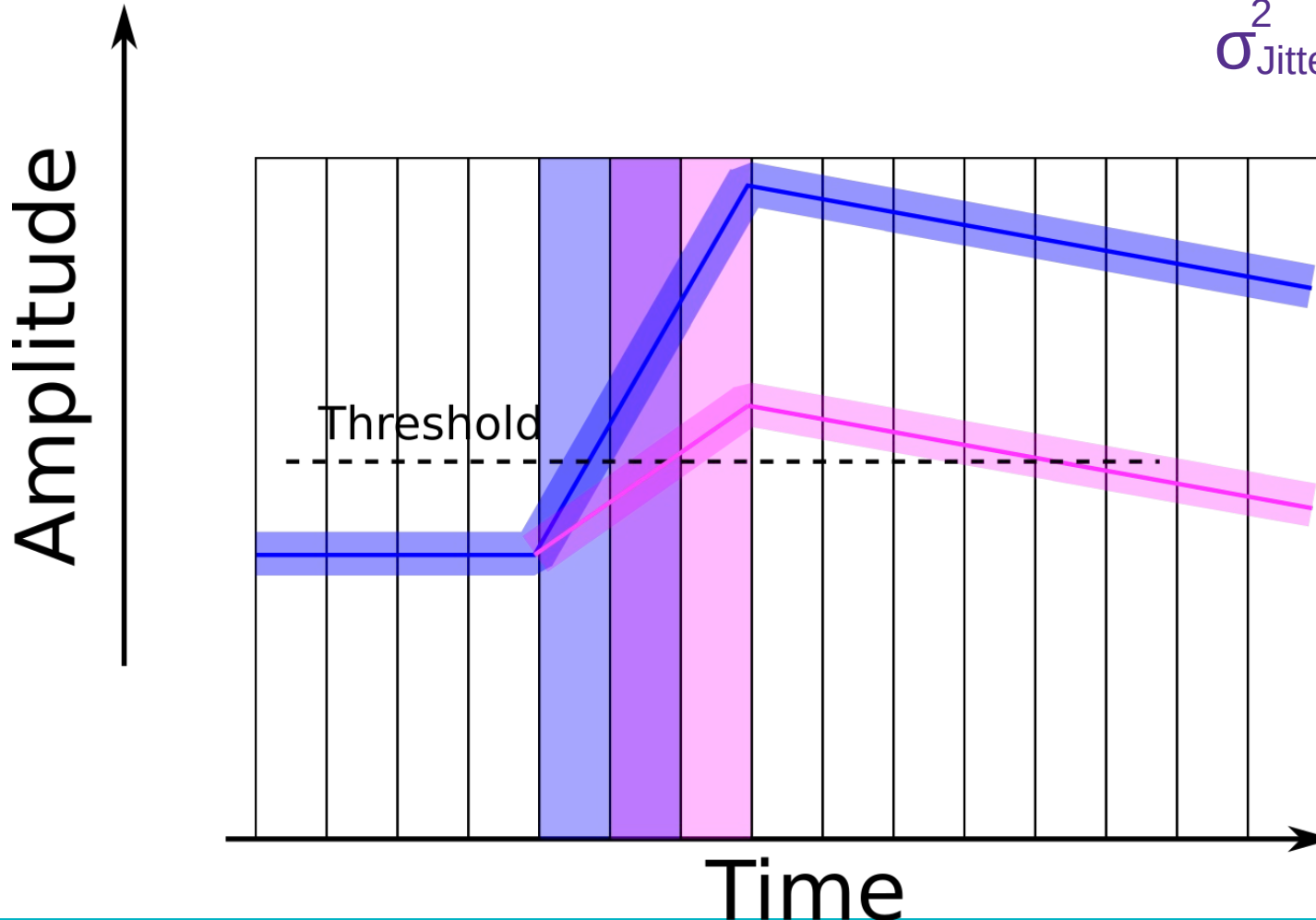
Contributions to time resolution

$$\sigma_t^2 = \sigma_{\text{clock-global}}^2 + \sigma_{\text{clock-on-chip}}^2 + \sigma_{\text{TDC}}^2 + \sigma_{\text{Timewalk}}^2 + \underbrace{\sigma_{\text{Landau}}^2 + \sigma_{\text{Front-end}}^2}_{\sigma_{\text{Jitter}}^2}$$



Contributions to time resolution

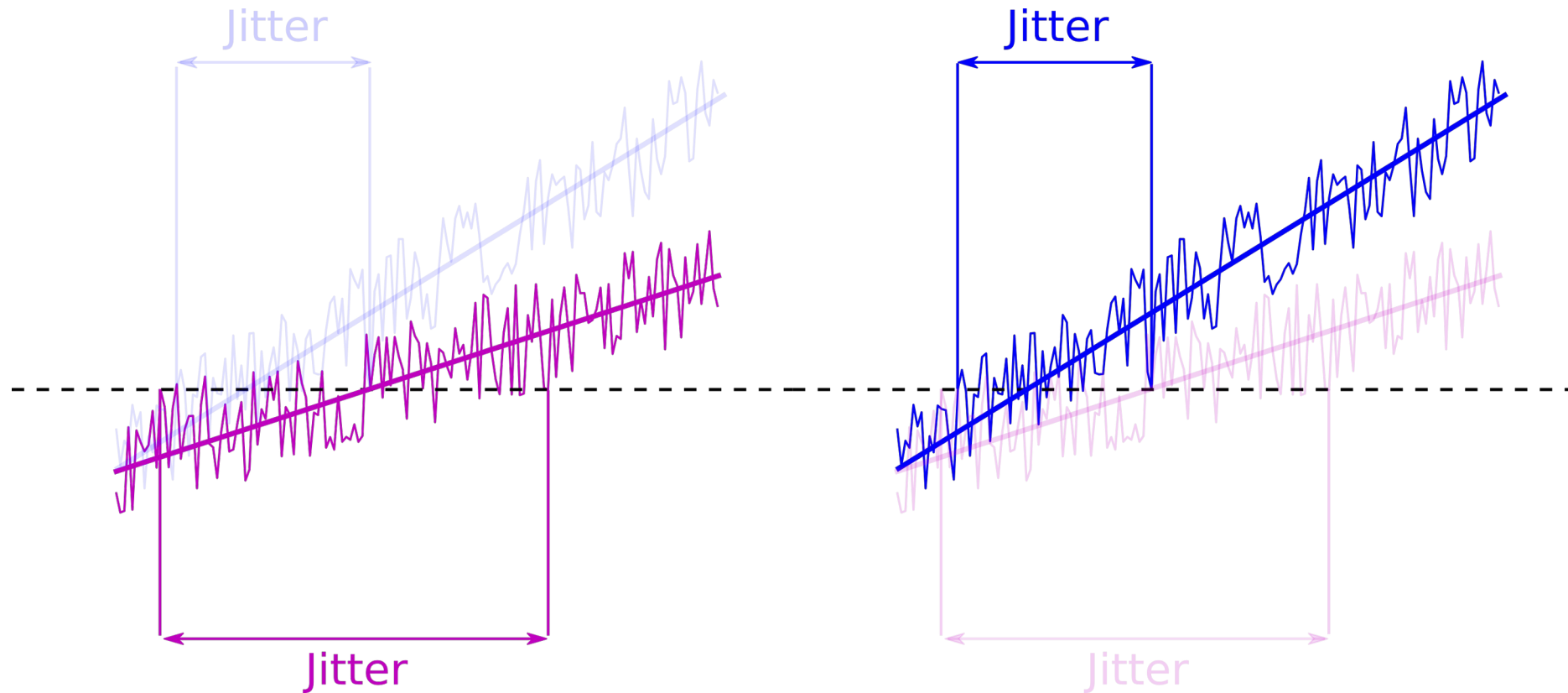
$$\sigma_t^2 = \sigma_{\text{clock-global}}^2 + \sigma_{\text{clock-on-chip}}^2 + \sigma_{\text{TDC}}^2 + \sigma_{\text{Timewalk}}^2 + \underbrace{\sigma_{\text{Landau}}^2 + \sigma_{\text{Front-end}}^2}_{\sigma_{\text{Jitter}}^2} (+ \sigma_{\text{Pixel-to-Pixel}}^2)$$



Removed through calibration, requires high statistics

Signal rise time

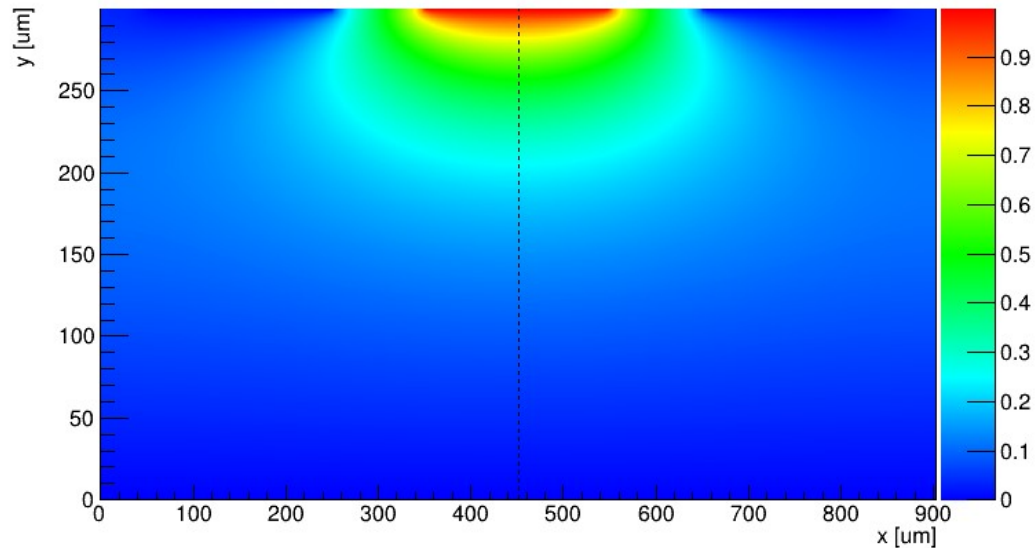
- Jitter depends on front-end noise and therefore capacitance
- For the same amount of noise a fast rising signal is impacted less for its time resolution



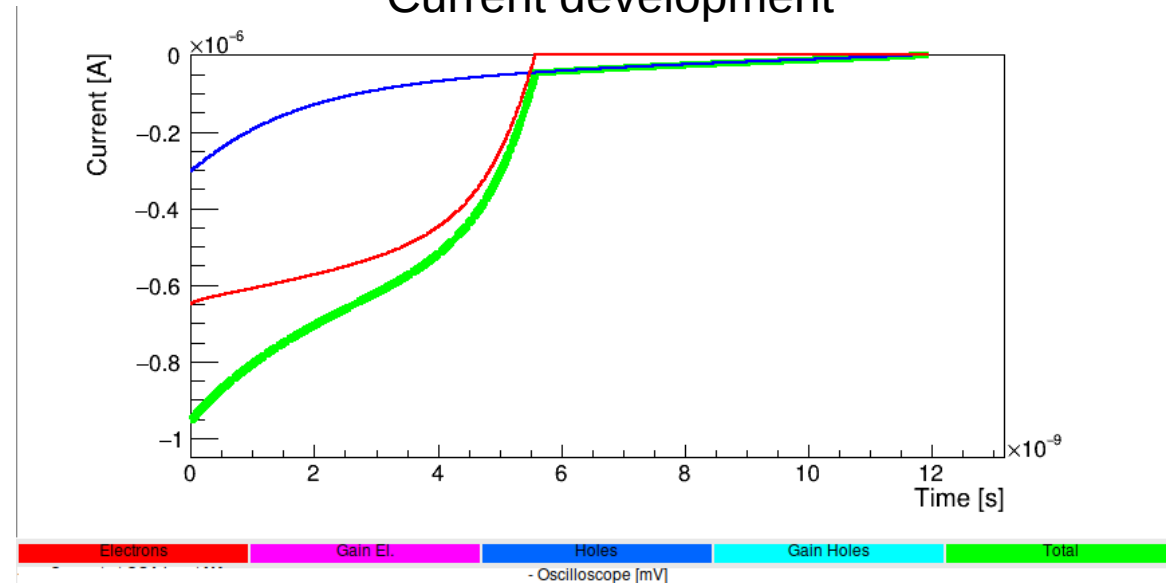
Signal rise time

- Geometry of electrodes plays a huge role in timing
- Affects the weighting potential
 - Affects the shape of the rising signal flank

Weighting Potential
(300 micron pitch 200 micron electrode)



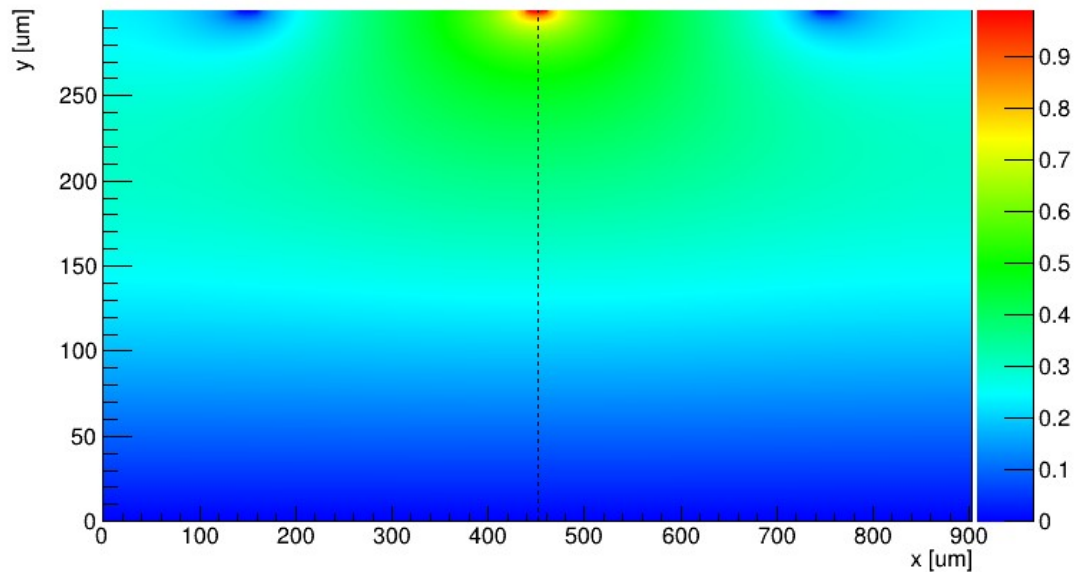
Current development



Signal rise time

- Geometry of electrodes plays a huge role in timing
- Affects the weighting potential
 - Affects the shape of the rising signal flank

Weighting Potential
(300 micron pitch 20 micron electrode)



Current development

